Sheet 1 of 1 JAN 2 8 2004 Form PTO-1449 ATTY DOCKET NO. APPLICATION NO. 45900-000757/US 10/658,774 & TRADE! INFORMATION DISCLOSURE CITATION APPLICANT CONF. NO. IN AN APPLICATION Henrik CHRISTENSEN et al. Unknown (Use several sheets if necessary) FILING DATE **GROUP** January 28, 2004 Unknown U.S. PATENT DOCUMENTS EXAMINER DOCUMENT NUMBER DATE NAME CLASS SUB FILING DATE INITIAL CLASS IF APPROPRIATE US 5,038,615 (2) 8/13/1991 Trulson et al. US 4.719.808 1/19/1988 Baumann et al. US 5,489,402 (R 2/6/1996 Knoblauch et al. 184 US 5,866,819 2/2/1999 Albu et al. US 6,250,159 6/26/2001 Kreier et al. 10 US 6,397,680 6/4/2002 Lévesque et al. US 5,974,886 11/2/1999 Carroll et al. US 5,197,019 3/23/1993 Delon-Martin et al. FOREIGN PATENT DOCUMENTS DOCUMENT NUMBER DATE COUNTRY TRANSLATION CLASS YES NO EP 0957337 11/17/1999 **EUROPE** XX EP 0897099 2/17/1999 **EUROPE** XX WO 02/19914 3/14/2002 WIPO XX 4/2/1984 JAPAN **ABST** JP 59057109 ... OTHER DOCUMENTS (Include Name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, ournal, serial, symposium, catalog, etc.) date, page(s), volume issue number(s), publisher, city and/or country where published. Johannes Büchler, et al., "High Precision Coating measurement with ultrasound", Proceedings of 15th World Conference on Non-Destructive Testing, Rome, October 15-21, 2000

Johannes Büchler, et al., "High Precision Coating measurement with ultrasound", Proceedings of 15th World Conference on Non-Destructive Testing, Rome, October 15-21, 2000

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